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Jameco Part Number 698357



8 Mbit (1Mb x 8) UV EPROM and OTP EPROM

Features

■ 5V ± 10% Supply Voltage in Read Operation

Access Time: 45 ns

■ Low Power Consumption:

- Active Current: 35 mA at 5 MHz

Standby Current: 100 μA

■ Programming Voltage: 12.75V ± 0.25V

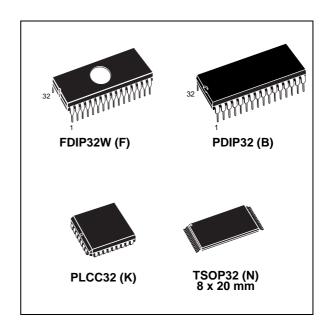
■ Programming Time: 50 µs/word

■ Electronic Signature

- Manufacturer Code: 20h

- Device Code: 42h

■ ECOPACK® packages available



Contents M27C801

Contents

• • • • • • • • • • • • • • • • • • • •	Summary description					
Devi	ce description	8				
2.1	Read mode	8				
2.2	Standby mode	8				
2.3	Two-line output control	8				
2.4	System considerations	9				
2.5	Programming	9				
2.6	Presto IIB programming algorithm	9				
2.7	Program Inhibit	10				
2.8	Program Verify	10				
2.9	Electronic Signature	10				
2.10	Erasure operation (applies to UV EPROM)	11				
Maxi	mum ratings	12				
DC a	nd AC characteristics	13				
Pack	age mechanical data	18				
5.1	32-pin Ceramic Frit-seal DIP, with round window (FDIP32WA)	18				
5.2	32-pin Plastic DIP, 600 mils width (PDIP32)	19				
5.3	32-lead Rectangular Plastic Leaded Chip Carrier (PLCC32)	20				
5.4	32-lead Plastic Thin Small Outline, 8x20 mm (TSOP32)	21				
Part	numbering	22				
Revis	sion history	23				
	2.1 2.2 2.3 2.4 2.5 2.6 2.7 2.8 2.9 2.10 Maxi DC a Pack 5.1 5.2 5.3 5.4 Part	Device description 2.1 Read mode 2.2 Standby mode 2.3 Two-line output control 2.4 System considerations 2.5 Programming 2.6 Presto IIB programming algorithm 2.7 Program Inhibit 2.8 Program Verify 2.9 Electronic Signature 2.10 Erasure operation (applies to UV EPROM) Maximum ratings DC and AC characteristics Package mechanical data 5.1 32-pin Ceramic Frit-seal DIP, with round window (FDIP32WA) 5.2 32-pin Plastic DIP, 600 mils width (PDIP32) 5.3 32-lead Rectangular Plastic Leaded Chip Carrier (PLCC32)				

M27C801 List of tables

List of tables

l able 1.	Signal descriptions	6
Table 2.	Operating Modes	8
Table 3.	Electronic Signature	11
Table 4.	Absolute Maximum Ratings	12
Table 5.	Read Mode DC Characteristics	13
Table 6.	Programming Mode DC Characteristics	13
Table 7.	AC Measurement Conditions	14
Table 8.	Capacitance	14
Table 9.	Read Mode AC Characteristics	15
Table 10.	Read Mode AC Characteristics	15
Table 11.	Margin Mode AC Characteristics	16
Table 12.	Programming Mode AC Characteristics	17
Table 13.	FDIP32WA package mechanical data	18
Table 14.	PDIP32 package mechanical data	19
Table 15.	PLCC32 package mechanical data	
Table 16.	TSOP32 package mechanical data	
Table 17.	Ordering Information Scheme	22
Table 18.	Document revision history	23

List of figures M27C801

List of figures

Figure 1.	Logic Diagram	5
Figure 2.	DIP connections	
Figure 3.	PLCC connections	7
Figure 4.	TSOP connections	7
Figure 5.	Programming flowchart	. 10
Figure 6.	AC Testing Input Output Waveform	. 14
Figure 7.	AC Testing Load Circuit	. 14
Figure 8.	Read Mode AC Waveforms	. 15
Figure 9.	Margin Mode AC Waveforms	. 16
Figure 10.	Programming and Verify Modes AC Waveforms	
Figure 11.	FDIP32WA package outline	. 18
Figure 12.	PDIP32 package outline	. 19
Figure 13.	PLCC32 package outline	. 20
Figure 14	TSOP32 package outline	21

Summary description 1

The M27C801 is an 8 Mbit EPROM offered in the two ranges UV (ultra violet erase) and OTP (one time programmable). It is ideally suited for applications where fast turn-around and pattern experimentation are important requirements and is organized as 1,048,576 by 8 bits.

The FDIP32W (window ceramic frit-seal package) has transparent lid which allows the user to expose the chip to ultraviolet light to erase the bit pattern. A new pattern can then be written to the device by following the programming procedure.

For applications where the content is programmed only one time and erasure is not required, the M27C801 is offered in PDIP32, PLCC32 and TSOP32 (8 x 20 mm) packages.

In order to meet environmental requirements, ST offers the M27C801 in ECOPACK® packages. ECOPACK packages are Lead-free. The category of second Level Interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label.

ECOPACK is an ST trademark. ECOPACK® specifications are available at: www.st.com.

See Figure 1: Logic Diagram and Table 1: Signal descriptions for a brief overview of the signals connected to this device.

Figure 1. **Logic Diagram VCC** M27C801 Vss AI01267

Summary description M27C801

Table 1. Signal descriptions

Signal	Description
A0-A19	Address Inputs
Q0-Q7	Data Outputs
Ē	Chip Enable
GV _{PP}	Output Enable / Program Supply
V _{CC}	Supply Voltage
V _{SS}	Ground

Figure 2. DIP connections

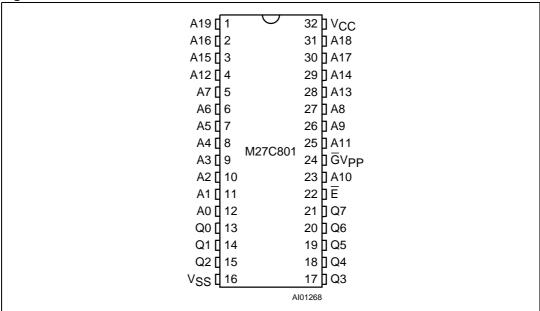


Figure 3. PLCC connections

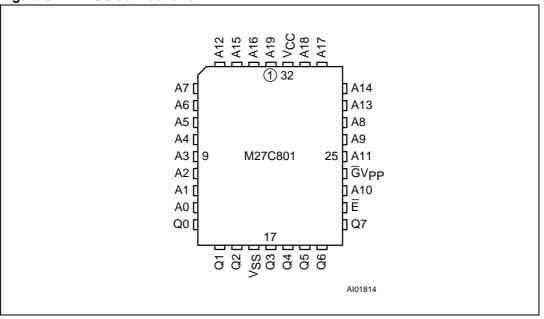
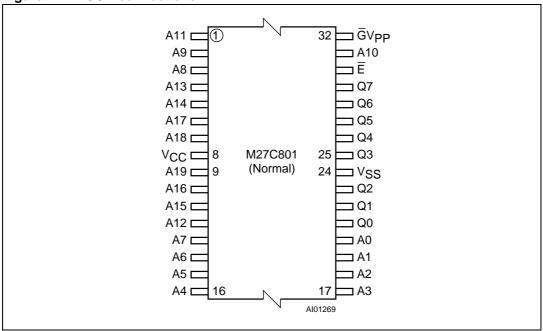


Figure 4. TSOP connections



Device description M27C801

2 Device description

The operating modes of the M27C801 are listed in the Operating Modes table. A single power supply is required in Read mode. All inputs are TTL levels except for \overline{GV}_{PP} and 12V on A9 for Electronic Signature and Margin Mode Set or Reset.

Table 2. Operating Modes ⁽¹⁾

Mode	Ē	ŪV _{pp}	А9	Q7-Q0
Read	V_{IL}	V_{IL}	Х	Data Out
Output Disable	V_{IL}	V _{IH}	X	Hi-Z
Program	V _{IL} Pulse	V_{PP}	X	Data In
Program Inhibit	V _{IH}	V _{PP}	Х	Hi-Z
Standby	V _{IH}	Х	Х	Hi-Z
Electronic Signature	V _{IL}	V _{IL}	V _{ID}	Codes

^{1.} $X = V_{IH} \text{ or } V_{IL}, V_{ID} = 12V \pm 0.5V.$

2.1 Read mode

The M27C801 has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable (\overline{E}) is the power control and should be used for device selection. Output Enable (\overline{G}) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that the addresses are stable, the address access time (t_{AVQV}) is equal to the delay from \overline{E} to output (t_{ELQV}) . Data is available at the output after a delay of t_{GLQV} from the falling edge of \overline{G} , assuming that \overline{E} has been low and the addresses have been stable for at least t_{AVQV} - t_{GLQV} .

2.2 Standby mode

The M27C801 has a standby mode which reduces the supply current from 35mA to 100µA.

The M27C801 is placed in the standby mode by applying a CMOS high signal to the \overline{E} input. When in the standby mode, the outputs are in a high impedance state, independent of the $\overline{G}V_{PP}$ input.

2.3 Two-line output control

Because EPROMs are usually used in larger memory arrays, the product features a 2 line control function which accommodates the use of multiple memory connection. The two line control function allows:

- the lowest possible memory power dissipation,
- complete assurance that output bus contention will not occur.

For the most efficient use of these two control lines, \overline{E} should be decoded and used as the primary device selecting function, while \overline{G} should be made a common connection to all devices in the array and connected to the \overline{READ} line from the system control bus. This

M27C801 Device description

ensures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is required from a particular memory device.

2.4 System considerations

The power switching characteristics of Advanced CMOS EPROMs require careful decoupling of the devices. The supply current, I_{CC} , has three segments that are of interest to the system designer: the standby current level, the active current level, and transient current peaks that are produced by the falling and rising edges of \overline{E} . The magnitude of the transient current peaks is dependent on the capacitive and inductive loading of the device at the output. The associated transient voltage peaks can be suppressed by complying with the two line output control and by properly selected decoupling capacitors. It is recommended that a $0.1\mu F$ ceramic capacitor be used on every device between V_{CC} and V_{SS} . This should be a high frequency capacitor of low inherent inductance and should be placed as close to the device as possible. In addition, a $4.7\mu F$ bulk electrolytic capacitor should be used between V_{CC} and V_{SS} for every eight devices. The bulk capacitor should be located near the power supply connection point. The purpose of the bulk capacitor is to overcome the voltage drop caused by the inductive effects of PCB traces.

2.5 Programming

When delivered (and after each erasure for UV EPROM), all bits of the M27C801 are in the '1' state. Data is introduced by selectively programming '0's into the desired bit locations. Although only '0' will be programmed, both '1's and '0's can be present in the data word. The only way to change a '0' to a '1' is by die exposure to ultraviolet light (UV EPROM). The M27C801 is in the programming mode when V_{PP} input is at 12.75V and \overline{E} is pulsed to V_{IL} . The data to be programmed is applied to 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL. V_{CC} is specified to be 6.25V \pm 0.25V.

2.6 Presto IIB programming algorithm

Presto IIB Programming Algorithm allows the whole array to be programmed with a guaranteed margin, in a typical time of 52.5 seconds. This can be achieved with STMicroelectronics M27C801 due to several design innovations to improve programming efficiency and to provide adequate margin for reliability. Before starting the programming the internal Margin Mode circuit is set in order to guarantee that each cell is programmed with enough margin. Then a sequence of 50 µs program pulses are applied to each byte until a correct Verify occurs (see *Figure 5*). No overprogram pulses are applied since the Verify in Margin Mode provides the necessary margin.

Device description M27C801

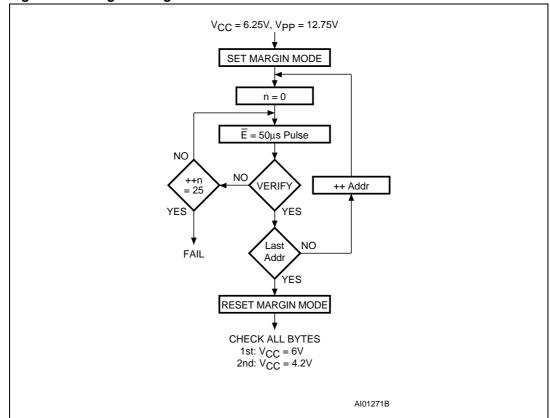


Figure 5. Programming flowchart

2.7 Program Inhibit

Programming of multiple M27C801s in parallel with different data is also easily accomplished. Except for \overline{E} , all like inputs including $\overline{GV_{PP}}$ of the parallel M27C801 may be common. A TTL low level pulse applied to a M27C801's \overline{E} input, with V_{PP} at 12.75V, will program that M27C801. A high level \overline{E} input inhibits the other M27C801s from being programmed.

2.8 Program Verify

A Verify (Read) should be performed on the programmed bits to determine that they were correctly programmed. The Verify is accomplished with \overline{G} at V_{IL} . Data should be verified with t_{ELOV} after the falling edge of \overline{E} .

2.9 Electronic Signature

The Electronic Signature (ES) mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment to automatically match the device to be programmed with its corresponding programming algorithm. The ES mode is functional in the 25° C \pm 5° C ambient temperature range that is required when programming the M27C801. To activate

M27C801 Device description

the ES mode, the programming equipment must force 11.5V to 12.5V on address line A9 of the M27C801. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from V_{IL} to V_{IH} . All other address lines must be held at V_{IL} during Electronic Signature mode. Byte 0 (A0 = V_{IL}) represents the manufacturer code and byte 1 (A0 = V_{IH}) the device identifier code. For the STMicroelectronics M27C801, these two identifier bytes are given in *Table 3* and can be read-out on outputs Q7 to Q0.

Table 3. Electronic Signature

Identifier	Α0	Q7	Q6	Q5	Q4	Q3	Q2	Q1	Q0	Hex Data
Manufacturer's Code	V_{IL}	0	0	1	0	0	0	0	0	20h
Device Code	V_{IH}	0	1	0	0	0	0	1	0	42h

2.10 Erasure operation (applies to UV EPROM)

The erasure characteristics of the M27C801 is such that erasure begins when the cells are exposed to light with wavelengths shorter than approximately 4000 Å. It should be noted that sunlight and some type of fluorescent lamps have wavelengths in the 3000-4000 Å range. Research shows that constant exposure to room level fluorescent lighting could erase a typical M27C801 in about 3 years, while it would take approximately 1 week to cause erasure when exposed to direct sunlight. If the M27C801 is to be exposed to these types of lighting conditions for extended periods of time, it is suggested that opaque labels be put over the M27C801 window to prevent unintentional erasure. The recommended erasure procedure for the M27C801 is exposure to short wave ultraviolet light which has wavelength 2537 Å. The integrated dose (i.e. UV intensity x exposure time) for erasure should be a minimum of 30 W-sec/cm². The erasure time with this dosage is approximately 30 to 40 minutes using an ultraviolet lamp with 12000 μ W/cm² power rating. The M27C801 should be placed within 2.5 cm (1 inch) of the lamp tubes during the erasure. Some lamps have a filter on their tubes which should be removed before erasure.

Maximum ratings M27C801

3 Maximum ratings

Table 4. Absolute Maximum Ratings (1)

Symbol	Parameter	Value	Unit
T _A	Ambient Operating Temperature (2)	-40 to 125	°C
T _{BIAS}	Temperature Under Bias	-50 to 125	°C
T _{STG}	Storage Temperature	-65 to 150	°C
V _{IO} (3)	Input or Output Voltage (except A9)	–2 to 7	V
V _{CC}	Supply Voltage	–2 to 7	V
V _{A9} (3)	A9 Voltage	–2 to 13.5	V
V _{PP}	Program Supply Voltage	–2 to 14	V

^{1.} Except for the rating "Operating Temperature Range", stresses above those listed in the Table "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

^{2.} Depends on range.

^{3.} Minimum DC voltage on Input or Output is -0.5V with possible undershoot to -2.0V for a period less than 20ns. Maximum DC voltage on Output is VCC +0.5V with possible overshoot to VCC +2V for a period less than 20ns.

4 DC and AC characteristics

 $T_A = 0$ to 70 °C or -40 to 85 °C; $V_{CC} = 5V \pm 10\%$

Table 5. Read Mode DC Characteristics (1)

Symbol	Parameter	Test Condition	Min.	Max.	Unit
I _{LI}	Input Leakage Current	$0V \le V_{IN} \le V_{CC}$		±10	μΑ
I _{LO}	Output Leakage Current	$0V \le V_{OUT} \le V_{CC}$		±10	μΑ
I _{CC}	Supply Current	$\overline{E} = V_{IL}, \overline{G}V_{PP} = V_{IL},$ $I_{OUT} = 0mA, f = 5MHz$		35	mA
I _{CC1}	Supply Current (Standby) TTL	E = V _{IH}		1	mA
I _{CC2}	Supply Current (Standby) CMOS	$\overline{E} > V_{CC} - 0.2V$		100	μА
I _{PP}	Program Current	$V_{PP} = V_{CC}$		10	μΑ
V _{IL}	Input Low Voltage		-0.3	0.8	V
V _{IH} ⁽²⁾	Input High Voltage		2	V _{CC} + 1	V
V _{OL}	Output Low Voltage	I _{OL} = 2.1mA		0.4	V
V.	Output High Voltage TTL	I _{OH} = -1mA	3.6		V
V _{OH}	Output High Voltage CMOS	$I_{OH} = -100 \mu A$	V _{CC} - 0.7		V

- 1. V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously or after V_{PP} .
- 2. Maximum DC voltage on Output is V_{CC} +0.5V.

 $T_A = 25 \, ^{\circ}\text{C}; \, V_{CC} = 6.25 \, \text{V} \pm 0.25 \, \text{V}; \, V_{PP} = 12.75 \, \text{V} \pm 0.25 \, \text{V}$

Table 6. Programming Mode DC Characteristics (1)

Symbol	Parameter	Test Condition	Min.	Max.	Unit
I _{LI}	Input Leakage Current	$V_{IL} \leq V_{IN} \leq V_{IH}$		±10	μΑ
I _{CC}	Supply Current			50	mA
I _{PP}	Program Current	E = V _{IL}		50	mA
V _{IL}	Input Low Voltage		-0.3	0.8	V
V _{IH}	Input High Voltage		2	V _{CC} + 0.5	V
V _{OL}	Output Low Voltage	I _{OL} = 2.1mA		0.4	V
V _{OH}	Output High Voltage TTL	$I_{OH} = -1mA$	3.6		V
V _{ID}	A9 Voltage		11.5	12.5	V

1. V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously or after V_{PP} .

577

Table 7. AC Measurement Conditions

Parameter	High Speed	Standard
Input Rise and Fall Times	≤ 10ns	≤ 20ns (10% to 90%)
Input Pulse Voltages	0 to 3V	0.4 to 2.4V
Input and Output Timing Ref. Voltages	1.5V	0.8 and 2V

 $T_A = 25$ °C, f = 1 MHz

Table 8. Capacitance (1)

Symbol	Parameter	Test Condition	Min.	Max.	Unit
C _{IN}	Input Capacitance	$V_{IN} = 0V$		6	pF
C _{OUT}	Output Capacitance	$V_{OUT} = 0V$		12	pF

^{1.} Sampled only, not 100% tested.

Figure 6. AC Testing Input Output Waveform

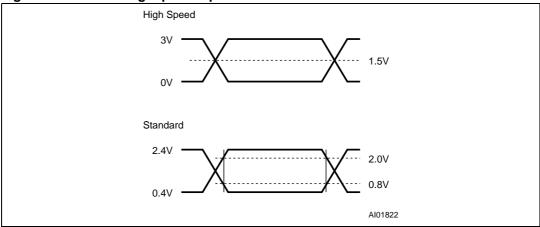
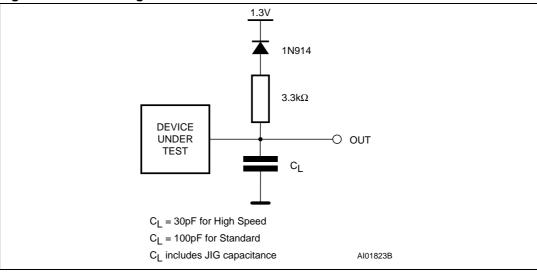


Figure 7. AC Testing Load Circuit



T_ :	= 0 to 7	0 °C or	-40 to 8	5 °C: '	$V_{CC} = 5V$	± 10%
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Table 9. Read Mode AC Characteristics (1)

Symbol	Alt	Parameter	Test	-45 ⁽²⁾		-55 ⁽²⁾		-60		Unit
Syllibol	Χil	raiailletei	Condition	Min.	Max.	Min.	Max.	Min.	Max.	Offic
t _{AVQV}	t _{ACC}	Address Valid to Output Valid	$\overline{E} = V_{IL},$ $\overline{G}V_{PP} = V_{IL}$		45		55		60	ns
t _{ELQV}	t _{CE}	Chip Enable Low to Output Valid	$\overline{G}V_{PP}=V_{IL}$		45		55		60	ns
t _{GLQV}	t _{OE}	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$		25		30		30	ns
t _{EHQZ} (3)	t _{DF}	Chip Enable High to Output Hi-Z	$\overline{G}V_{PP}=V_{IL}$	0	25	0	25	0	25	ns
t _{GHQZ} (3)	t _{DF}	Output Enable High to Output Hi-Z	$\overline{E} = V_{IL}$	0	25	0	25	0	25	ns
t _{AXQX}	t _{OH}	Address Transition to Output Transition	$\overline{\overline{G}} = V_{IL}, \\ \overline{G} V_{PP} = V_{IL}$	0		0		0		ns

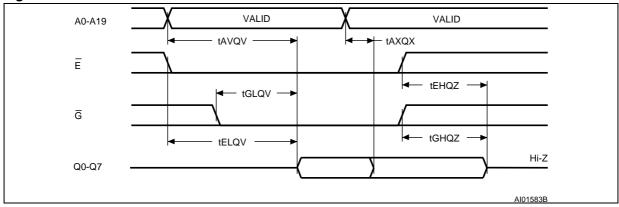
- 1. V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously or after V_{PP} .
- 2. Speed obtained with High Speed AC measurement conditions.
- 3. Sampled only, not 100% tested.

Table 10. Read Mode AC Characteristics (1)

Symbol	Alt	Parameter	Test	-70		-80		-100/-120/-150		Unit
Symbol	ΧII	raiailletei	Condition	Min.	Max.	Min.	Max.	Min	Max.	Olik
t _{AVQV}	t _{ACC}	Address Valid to Output Valid $\frac{\overline{E} = V_{IL}}{\overline{G}V_{PP} = V_{IL}}$ 70			80		100	ns		
t _{ELQV}	t _{CE}	Chip Enable Low to Output Valid	$\overline{G}V_{PP}=V_{IL}$		70		80		100	ns
t _{GLQV}	t _{OE}	Output Enable Low to Output Valid	$\overline{E} = V_{IL}$		35		40		50	ns
t _{EHQZ} (2)	t _{DF}	Chip Enable High to Output Hi-Z	$\overline{G}V_{PP}=V_{IL}$	0	30	0	35	0	40	ns
t _{GHQZ} (2)	t _{DF}	Output Enable High to Output Hi-Z	$\overline{E} = V_{IL}$	0	30	0	35	0	40	ns
t _{AXQX}	t _{OH}	Address Transition to Output Transition	$\overline{\overline{G}} = V_{IL},$ $\overline{G}V_{PP} = V_{IL}$	0		0		0		ns

- 1. V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously or after V_{PP} .
- 2. Sampled only, not 100% tested.

Figure 8. Read Mode AC Waveforms



577

 $T_A = 25$ °C; $V_{CC} = 6.25V \pm 0.25V$; $V_{PP} = 12.75V \pm 0.25V$

Table 11. Margin Mode AC Characteristics (1)

Symbol	Alt	Parameter	Test Condition	Min	Max	Unit
t _{A9HVPH}	t _{AS9}	V _{A9} High to V _{PP} High		2		μs
t _{VPHEL}	t _{VPS}	V _{PP} High to Chip Enable Low		2		μs
t _{A10HEH}	t _{AS10}	V _{A10} High to Chip Enable High (Set)		1		μs
t _{A10LEH}	t _{AS10}	V _{A10} Low to Chip Enable High (Reset)		1		μs
t _{EXA10X}	t _{AH10}	Chip Enable Transition to V _{A10} Transition		1		μs
t _{EXVPX}	t _{VPH}	Chip Enable Transition to V _{PP} Transition		2		μs
t _{VPXA9X}	t _{AH9}	V _{PP} Transition to V _{A9} Transition		2		μs

^{1.} V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously or after V_{PP} .

Figure 9. Margin Mode AC Waveforms

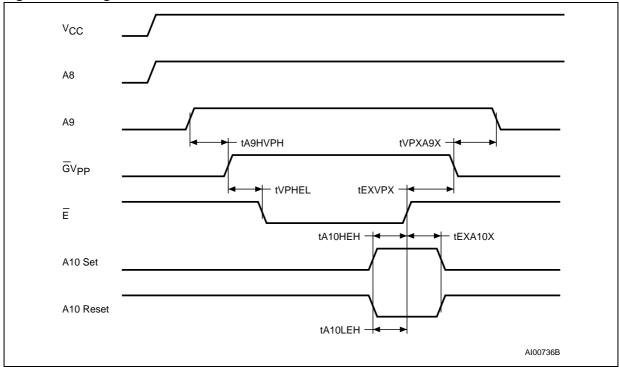
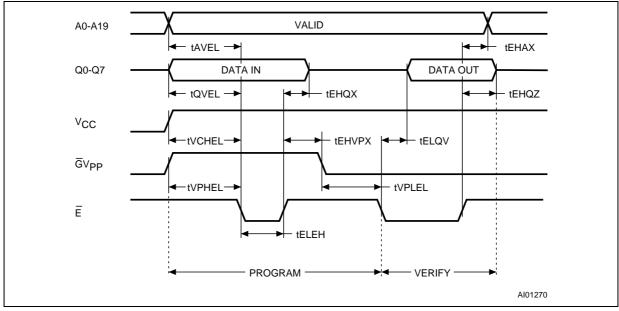


Table 12. Programming Mode AC Characteristics (1)

Symbol	Alt	Parameter	Test Condition	Min.	Max.	Unit
t _{AVEL}	t _{AS}	Address Valid to Chip Enable Low		2		μs
t _{QVEL}	t _{DS}	Input Valid to Chip Enable Low		2		μs
t _{VCHEL}	t _{VCS}	V _{CC} High to Chip Enable Low		2		μs
t _{VPHEL}	t _{OES}	V _{PP} High to Chip Enable Low		2		μs
t _{VPLVPH}	t _{PRT}	V _{PP} Rise Time		50		ns
t _{ELEH}	t _{PW}	Chip Enable Program Pulse Width (Initial)		45	55	μs
t _{EHQX}	t _{DH}	Chip Enable High to Input Transition		2		μs
t _{EHVPX}	t _{OEH}	Chip Enable High to V _{PP} Transition		2		μs
t _{VPLEL}	t _{VR}	V _{PP} Low to Chip Enable Low		2		μs
t _{ELQV}	t _{DV}	Chip Enable Low to Output Valid			1	μs
t _{EHQZ} (2)	t _{DFP}	Chip Enable High to Output Hi-Z		0	130	ns
t _{EHAX}	t _{AH}	Chip Enable High to Address Transition		0		ns

^{1.} V_{CC} must be applied simultaneously with or before V_{PP} and removed simultaneously or after V_{PP} .

Figure 10. Programming and Verify Modes AC Waveforms



^{2.} Sampled only, not 100% tested.

5 Package mechanical data

5.1 32-pin Ceramic Frit-seal DIP, with round window (FDIP32WA)

Figure 11. FDIP32WA package outline

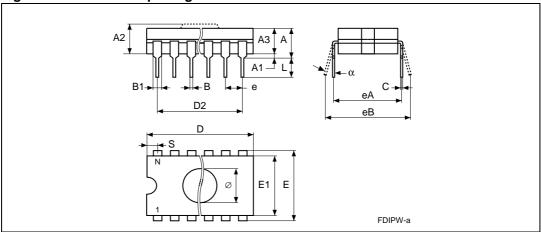


Table 13. FDIP32WA package mechanical data

Table 13.	LDIE25MA P	ackage med	nanicai data	l				
Cumbal		millimeters		inches				
Symbol	Min	Тур	Max	Min	Тур	Max		
А			5.72			0.225		
A1	0.51		1.40	0.020		0.055		
A2	3.91		4.57	0.154		0.180		
A3	3.89		4.50	0.153		0.177		
В	0.41		0.56	0.016		0.022		
B1		1.45			0.057			
С	0.23		0.30	0.009		0.012		
D	41.73		42.04	1.643		1.655		
D2		38.10			1.500			
е		2.54			0.100			
Е		15.24			0.600			
E1	13.06		13.36	0.514		0.526		
eA		14.99			0.590			
eB	16.18		18.03	0.637		0.710		
L	3.18		4.10	0.125		0.161		
N		32			32			
S	1.52		2.49	0.060		0.098		
Ø		7.11			0.280			
α	4°		11°	4°		11°		

5.2 32-pin Plastic DIP, 600 mils width (PDIP32)

Figure 12. PDIP32 package outline

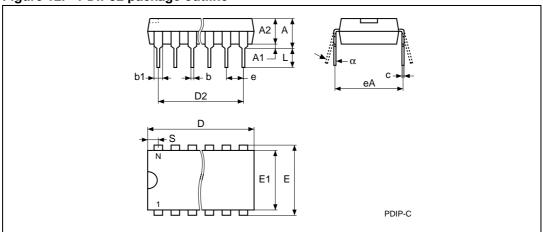


Table 14. PDIP32 package mechanical data

Cymphal		millimeters		inches				
Symbol	Min	Тур	Max	Min	Тур	Max		
А			4.83			0.190		
A1	0.38			0.015				
A2		3.81			0.150			
b	0.41		0.53	0.016		0.021		
b1	1.14		1.65	0.045		0.065		
С	0.23		0.38	0.009		0.015		
D	41.78		42.29	1.645		1.665		
D2		38.10			1.500			
eA		15.24			0.600			
е		2.54			0.100			
Е	15.24		15.88	0.600		0.625		
E1	13.46		13.97	0.530		0.550		
S	1.65		2.21	0.065		0.087		
L	3.05		3.56	0.120		0.140		
α	0°		15°	0°		15°		
N		32			32			

577

5.3 32-lead Rectangular Plastic Leaded Chip Carrier (PLCC32)

Figure 13. PLCC32 package outline

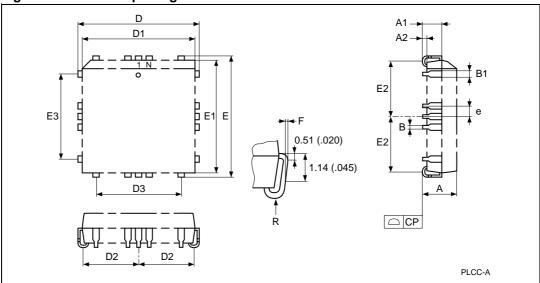


Table 15. PLCC32 package mechanical data

Combal		millimeters		inches				
Symbol	Min	Тур	Max	Min	Тур	Max		
А	3.18		3.56	0.125		0.140		
A1	1.53		2.41	0.060		0.095		
A2	0.38		-	0.015		-		
В	0.33		0.53	0.013		0.021		
B1	0.66		0.81	0.026		0.032		
СР			0.10			0.004		
D	12.32		12.57	0.485		0.495		
D1	11.35		11.51	0.447		0.453		
D2	4.78		5.66	0.188		0.223		
D3		7.62			0.300			
E	14.86		15.11	0.585		0.595		
E1	13.89		14.05	0.547		0.553		
E2	6.05		6.93	0.238		0.273		
E3		10.16			0.400			
е		1.27			0.050			
F	0.00		0.13	0.000		0.005		
R		0.89			0.035			
N		32			32			

5.4 32-lead Plastic Thin Small Outline, 8x20 mm (TSOP32)

Figure 14. TSOP32 package outline

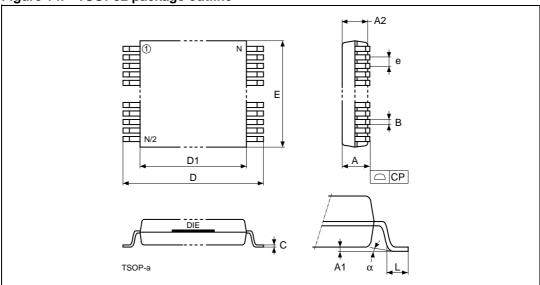


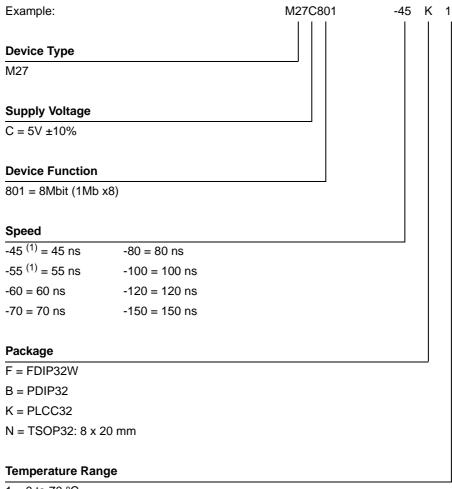
Table 16. TSOP32 package mechanical data

Symbol		millimeters		inches				
Symbol	Min	Тур	Max	Min	Тур	Max		
А			1.200			0.0472		
A1	0.050		0.150	0.0020		0.0059		
A2	0.950		1.050	0.0374		0.0413		
В	0.170		0.250	0.0067		0.0098		
С	0.100		0.210	0.0039		0.0083		
СР			0.100			0.0039		
D	19.800		20.200	0.7795		0.7953		
D1	18.300		18.500	0.7205		0.7283		
е		0.500			0.0197			
E	7.900		8.100	0.3110		0.3189		
L	0.500		0.700	0.0197		0.0276		
N		32			32			
α	0°		5°	0°		5°		

Part numbering M27C801

6 Part numbering

Table 17. Ordering Information Scheme



^{1 = 0} to 70 °C

 $6 = -40 \text{ to } 85 \text{ }^{\circ}\text{C}$

For a list of available options (Speed, Package, etc...) or for further information on any aspect of this device, please contact the STMicroelectronics Sales Office nearest to you.

^{1.} High Speed, see AC Characteristics section for further information.

M27C801 Revision history

7 Revision history

Table 18. Document revision history

Date	Revision	Changes
10-Sept-1998 1 F		First Issue
21-Mar-2000	21-Mar-2000 2 FDIP32W Package changed	
25-Sep-2000	3	AN620 Reference removed
12-Jul-2002 4		55ns speed class added PLCC32 Package mechanical drawing and data clarified
12-Apr-2006	5	Converted to new template. Added ECOPACK® information. Removed Tape & Reel Packing option.

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577